


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/688,922	EZAWA ET AL.	
	Examiner	Art Unit	
	Nhan T. Tran	2622	

SEARCHED			
Class	Subclass	Date	Examiner
348	362 344	4/10/2007	NT
396	194 220	4/12/2007	NT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	4/10/2007	NT
348/362-369 (text search - see search history printout)	4/10/2007	NT
Parent case 09/174095 references and IDS checked	4/10/2007	NT